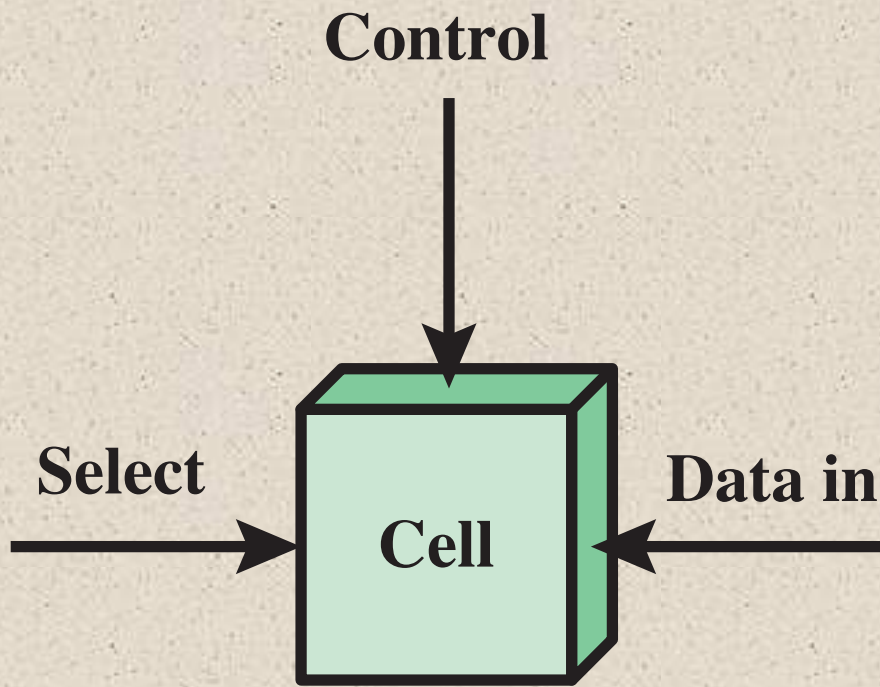


**William Stallings  
Computer Organization  
and Architecture  
10<sup>th</sup> Edition**

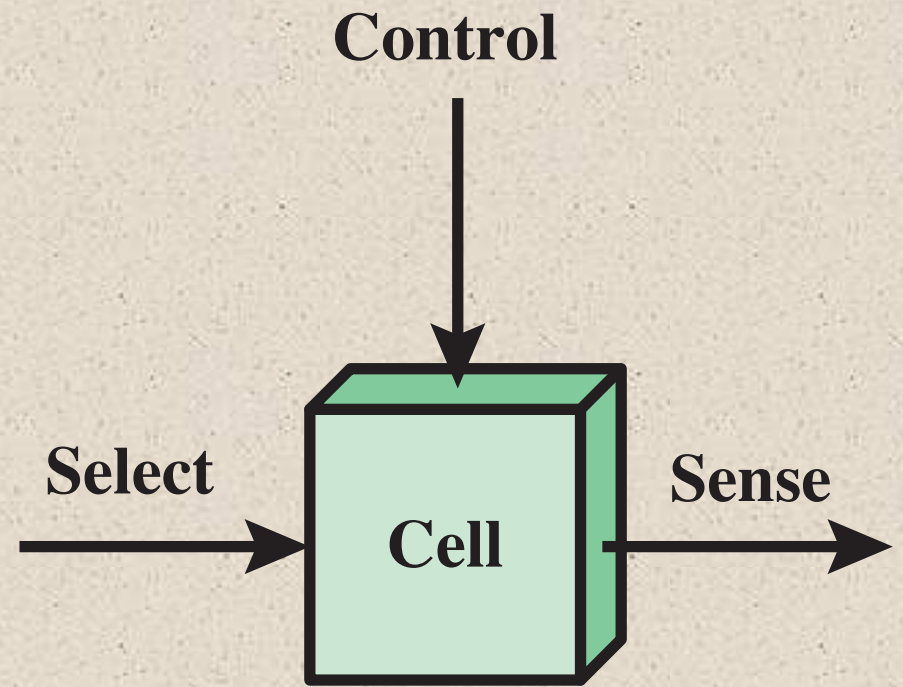


# + Chapter 5

## Internal Memory




**(a) Write**



**(b) Read**

**Figure 5.1 Memory Cell Operation**

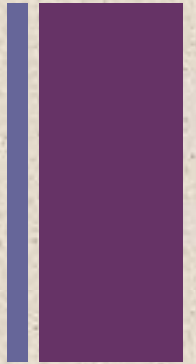


<b>Memory Type</b>	<b>Category</b>	<b>Erase</b>	<b>Write Mechanism</b>	<b>Volatility</b>
Random-access memory (RAM)	Read-write memory	Electrically, byte-level	Electrically	Volatile
Read-only memory (ROM)	Read-mostly memory	Not possible	Masks	Nonvolatile
Programmable ROM (PROM)			Electrically	
Erasable PROM (EPROM)		UV light, chip-level		
Electrically Erasable PROM (EEPROM)		Electrically, byte-level		
Flash memory		Electrically, block-level		

**Table 5.1**  
**Semiconductor Memory Types**

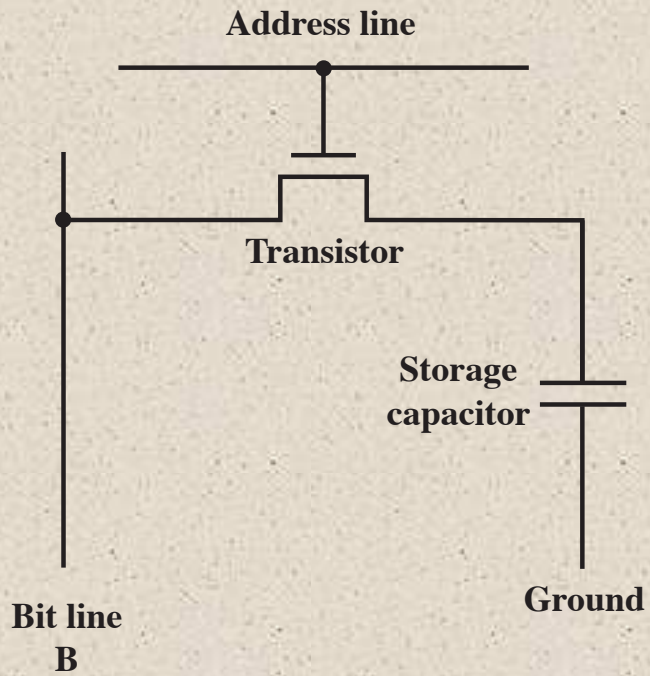


# Dynamic RAM (DRAM)

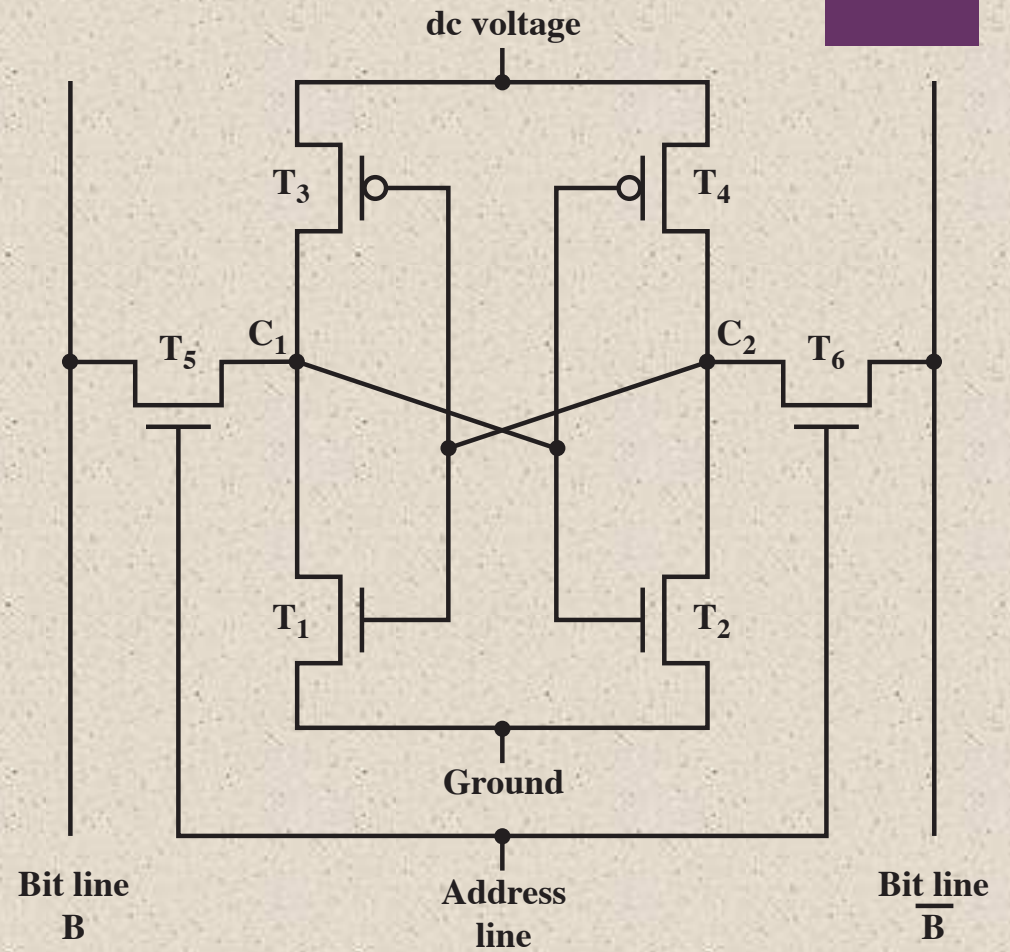


- RAM technology is divided into two technologies:
  - Dynamic RAM (DRAM)
  - Static RAM (SRAM)
  
- DRAM
  - Made with cells that store data as charge on capacitors
  - Presence or absence of charge in a capacitor is interpreted as a binary 1 or 0
  - Requires periodic charge refreshing to maintain data storage
  - The term *dynamic* refers to tendency of the stored charge to leak away, even with power continuously applied





(a) Dynamic RAM (DRAM) cell



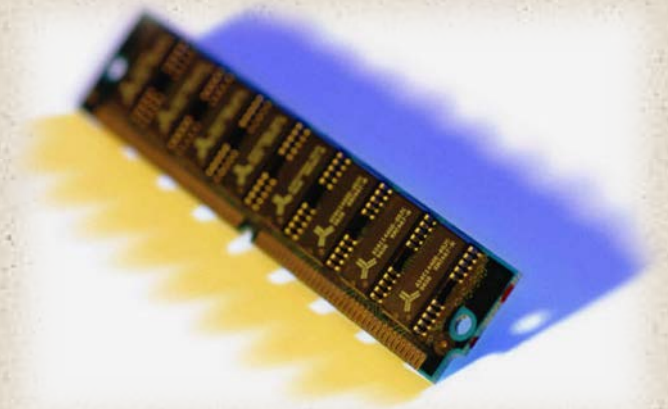
(b) Static RAM (SRAM) cell

**Figure 5.2 Typical Memory Cell Structures**



# Static RAM (SRAM)

- Digital device that uses the same logic elements used in the processor
- Binary values are stored using traditional flip-flop logic gate configurations
- Will hold its data as long as power is supplied to it



# SRAM versus DRAM

SRAM

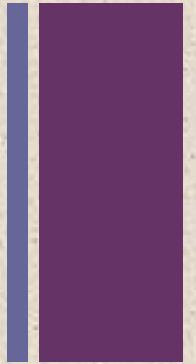
DRAM

- Both volatile
  - Power must be continuously supplied to the memory to preserve the bit values
- Dynamic cell
  - Simpler to build, smaller
  - More dense (smaller cells = more cells per unit area)
  - Less expensive
  - Requires the supporting refresh circuitry
  - Tend to be favored for large memory requirements
  - Used for main memory
- Static
  - Faster
  - Used for cache memory (both on and off chip)





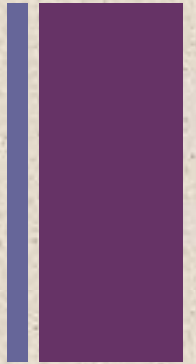
# Read Only Memory (ROM)



- Contains a permanent pattern of data that cannot be changed or added to
- No power source is required to maintain the bit values in memory
- Data or program is permanently in main memory and never needs to be loaded from a secondary storage device
- Data is actually wired into the chip as part of the fabrication process
  - Disadvantages of this:
    - No room for error, if one bit is wrong the whole batch of ROMs must be thrown out
    - Data insertion step includes a relatively large fixed cost



# Programmable ROM (PROM)



- Less expensive alternative
- Nonvolatile and may be written into only once
- Writing process is performed electrically and may be performed by supplier or customer at a time later than the original chip fabrication
- Special equipment is required for the writing process
- Provides flexibility and convenience
- Attractive for high volume production runs

# Read-Mostly Memory

## EPROM

Erasable programmable read-only memory

Erasure process can be performed repeatedly

More expensive than PROM but it has the advantage of the multiple update capability

## EEPROM

Electrically erasable programmable read-only memory

Can be written into at any time without erasing prior contents

Combines the advantage of non-volatility with the flexibility of being updatable in place

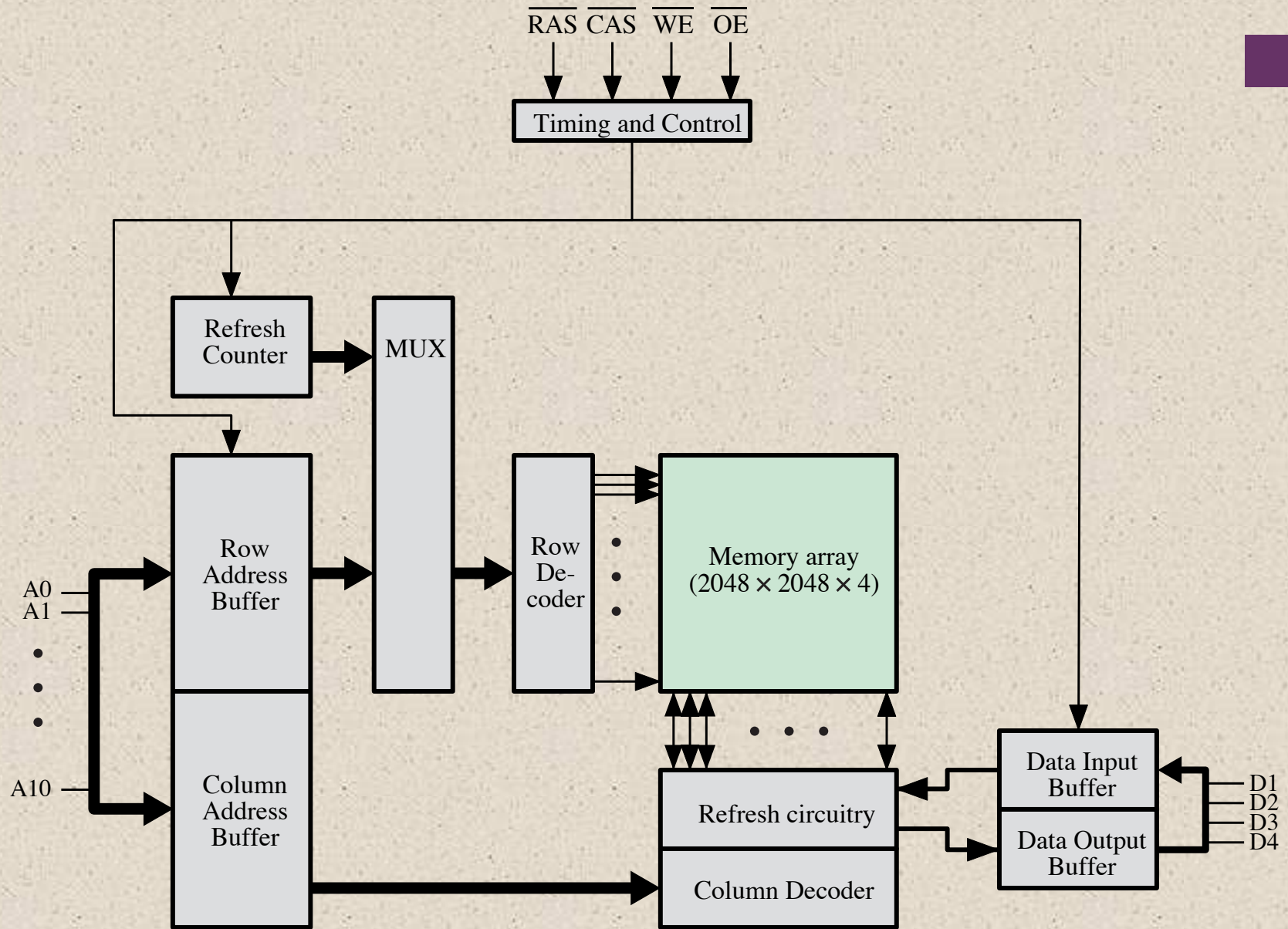
More expensive than EPROM

## Flash Memory

Intermediate between EPROM and EEPROM in both cost and functionality

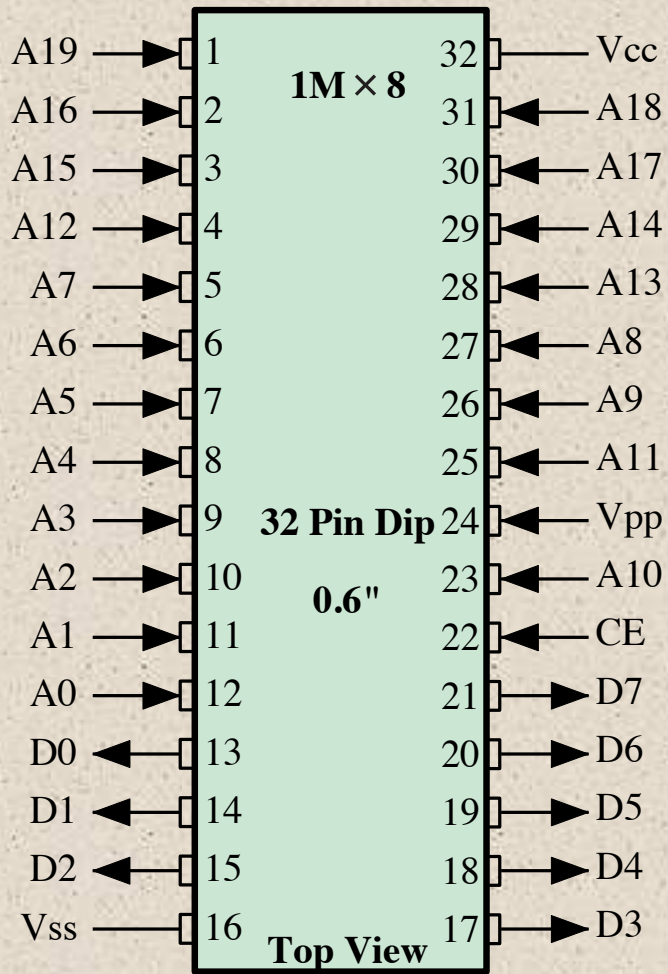
Uses an electrical erasing technology, does not provide byte-level erasure

Microchip is organized so that a section of memory cells are erased in a single action or "flash"

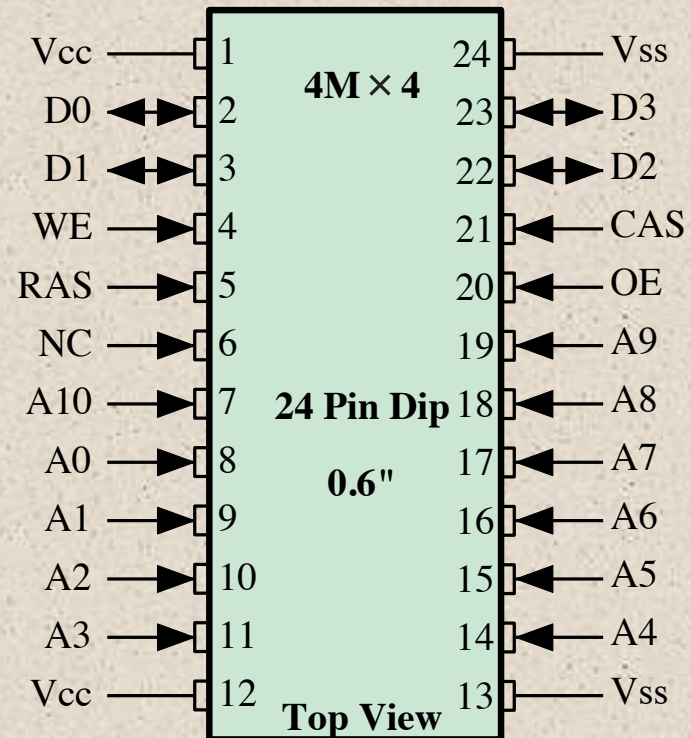


**Figure 5.3 Typical 16 Megabit DRAM (4M x 4)**





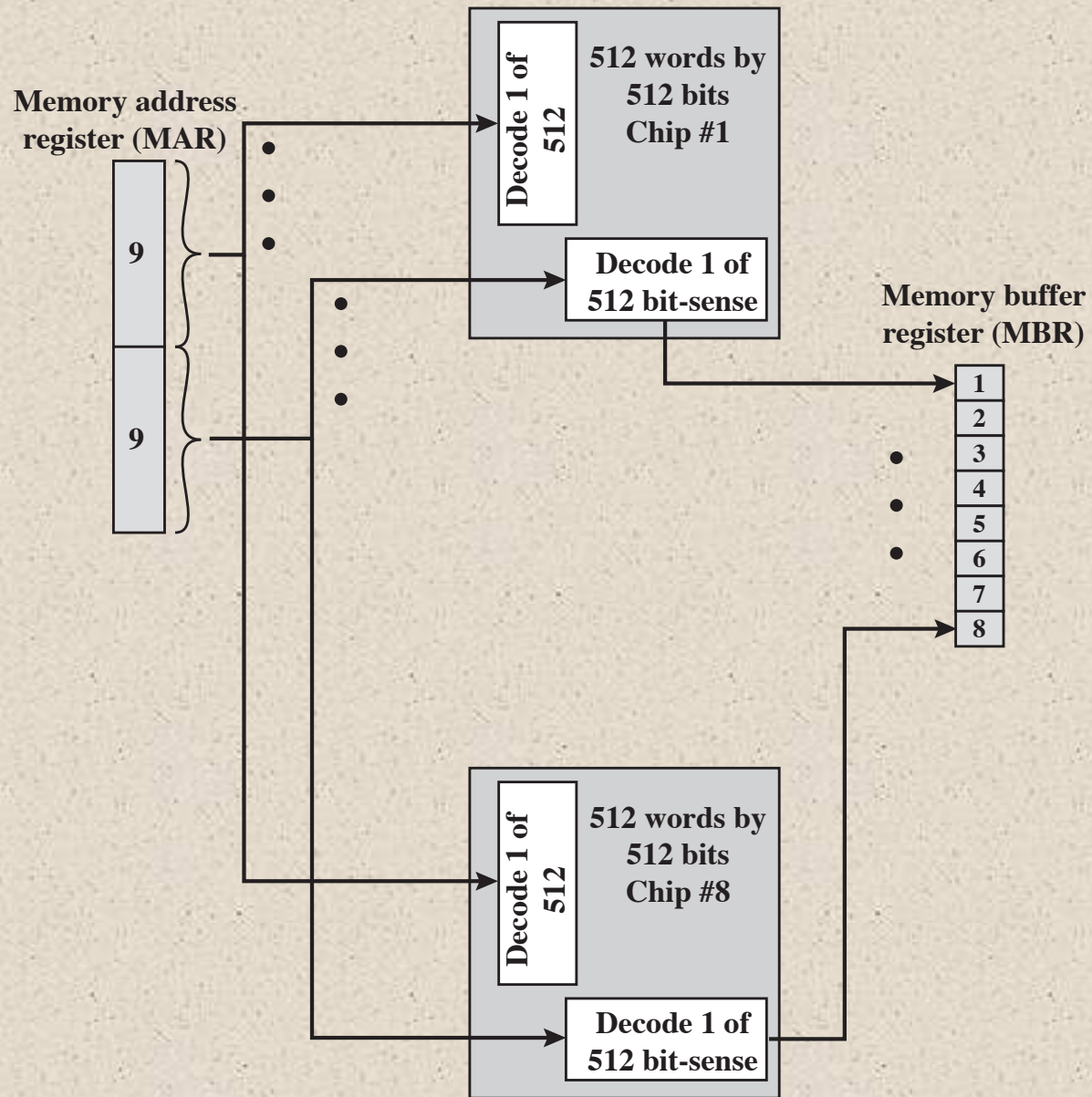
(a) 8 Mbit EPROM



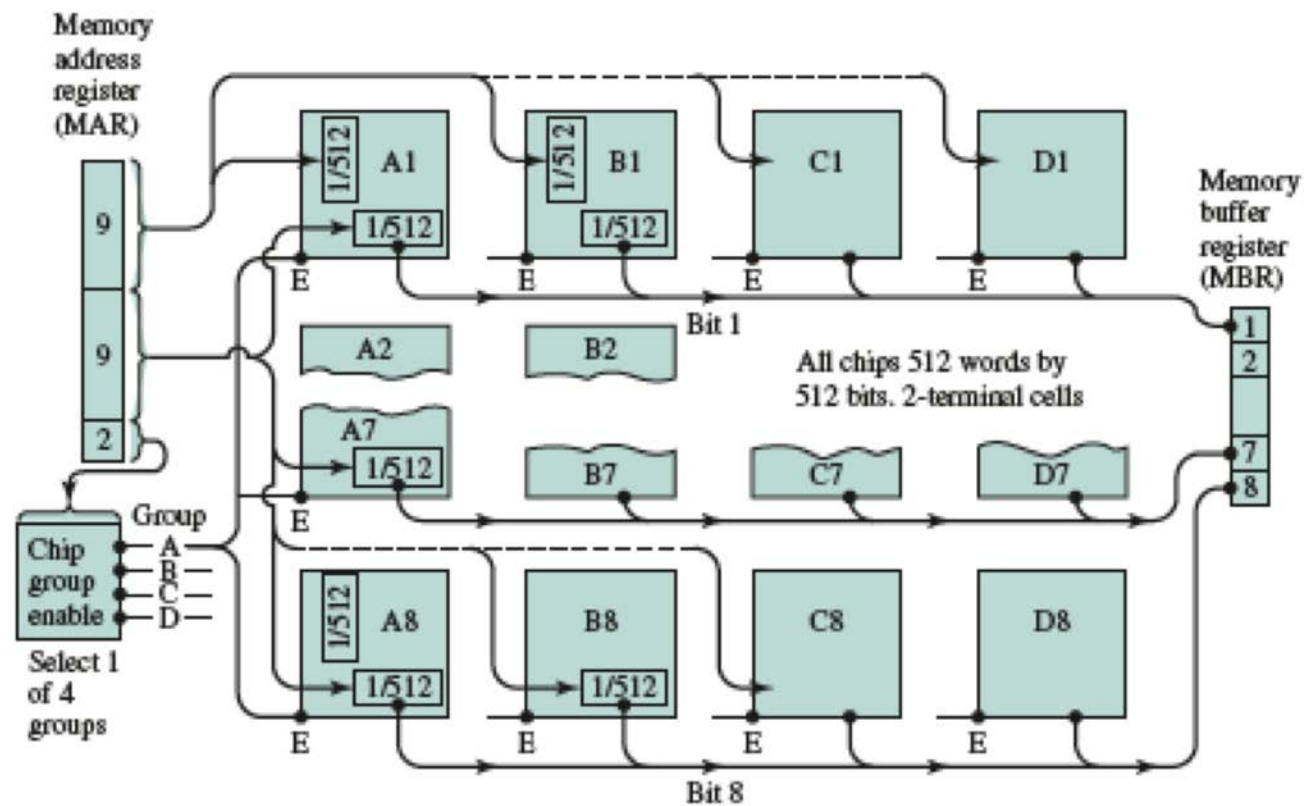
(b) 16 Mbit DRAM

**Figure 5.4 Typical Memory Package Pins and Signals**



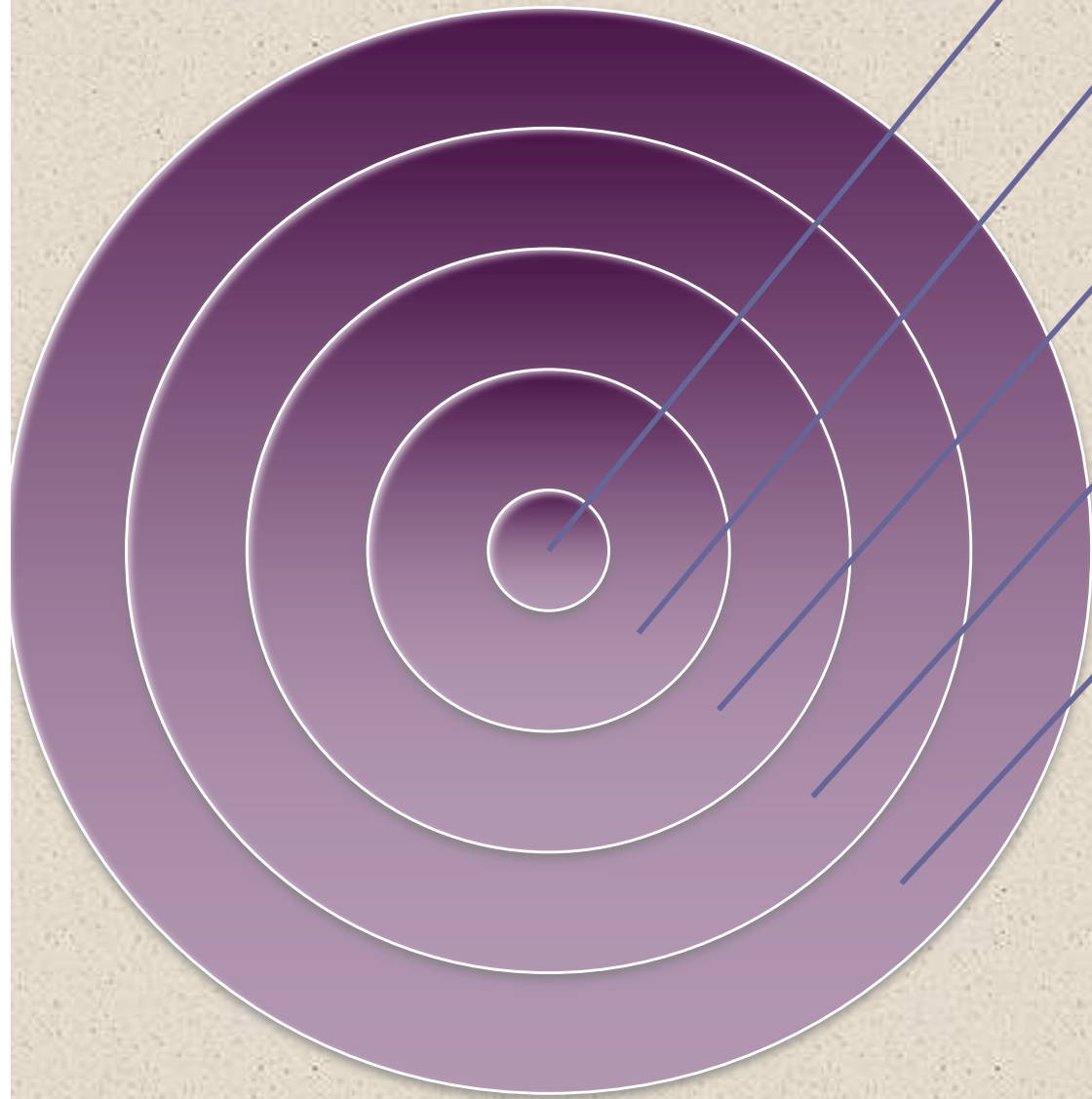


**Figure 5.5 256-KByte Memory Organization**



**Figure 5.6** 1-Mbyte Memory Organization

# Interleaved Memory



Composed of a collection of DRAM chips

Grouped together to form a *memory bank*

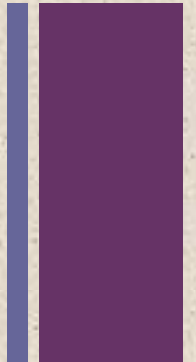
Each bank is independently able to service a memory read or write request

$K$  banks can service  $K$  requests simultaneously, increasing memory read or write rates by a factor of  $K$

If consecutive words of memory are stored in different banks, the transfer of a block of memory is speeded up



# Error Correction



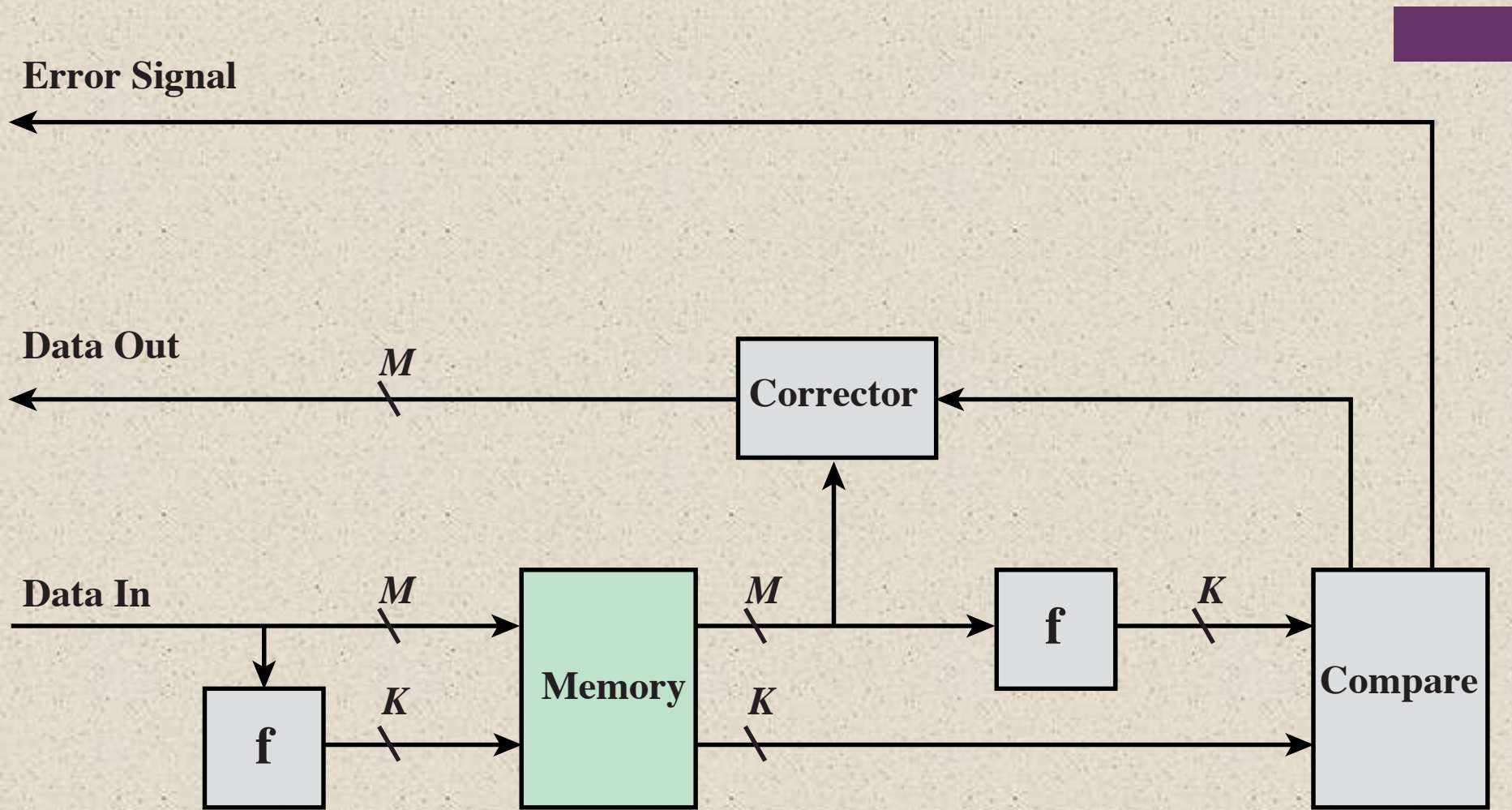
## ■ Hard Failure

- Permanent physical defect
- Memory cell or cells affected cannot reliably store data but become stuck at 0 or 1 or switch erratically between 0 and 1
- Can be caused by:
  - Harsh environmental abuse
  - Manufacturing defects
  - Wear

## ■ Soft Error

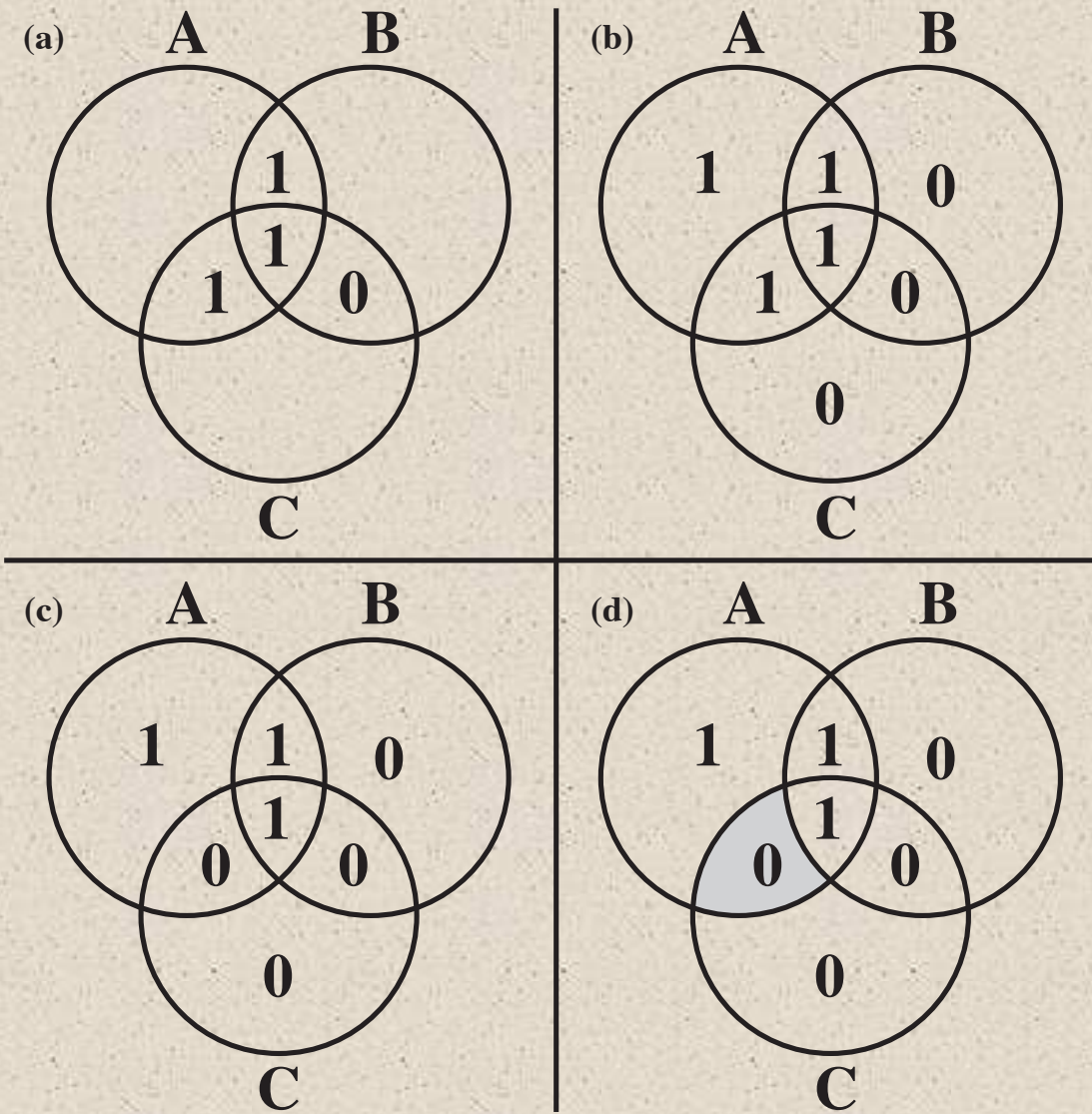
- Random, non-destructive event that alters the contents of one or more memory cells
- No permanent damage to memory
- Can be caused by:
  - Power supply problems
  - Alpha particles





**Figure 5.7 Error-Correcting Code Function**





**Figure 5.8 Hamming Error-Correcting Code**



	Single-Error Correction		Single-Error Correction/ Double-Error Detection	
Data Bits	Check Bits	% Increase	Check Bits	% Increase
8	4	50	5	62.5
16	5	31.25	6	37.5
32	6	18.75	7	21.875
64	7	10.94	8	12.5
128	8	6.25	9	7.03
256	9	3.52	10	3.91

**Table 5.2**  
**Increase in Word Length with Error Correction**



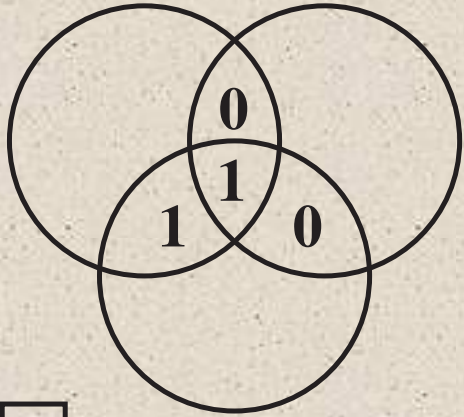
<b>Bit Position</b>	12	11	10	9	8	7	6	5	4	3	2	1
<b>Position Number</b>	1100	1011	1010	1001	1000	0111	0110	0101	0100	0011	0010	0001
<b>Data Bit</b>	D8	D7	D6	D5		D4	D3	D2		D1		
<b>Check Bit</b>					C8				C4		C2	C1

**Figure 5.9 Layout of Data Bits and Check Bits**

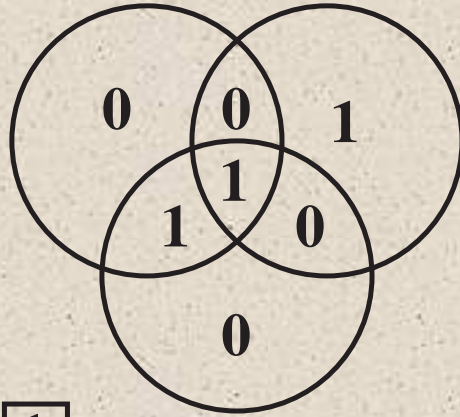
<b>Bit position</b>	12	11	10	9	8	7	6	5	4	3	2	1
<b>Position number</b>	1100	1011	1010	1001	1000	0111	0110	0101	0100	0011	0010	0001
<b>Data bit</b>	D8	D7	D6	D5		D4	D3	D2		D1		
<b>Check bit</b>					C8				C4		C2	C1
<b>Word stored as</b>	0	0	1	1	0	1	0	0	1	1	1	1
<b>Word fetched as</b>	0	0	1	1	0	1	1	0	1	1	1	1
<b>Position Number</b>	1100	1011	1010	1001	1000	0111	0110	0101	0100	0011	0010	0001
<b>Check Bit</b>					0				0		0	1

**Figure 5.10 Check Bit Calculation**

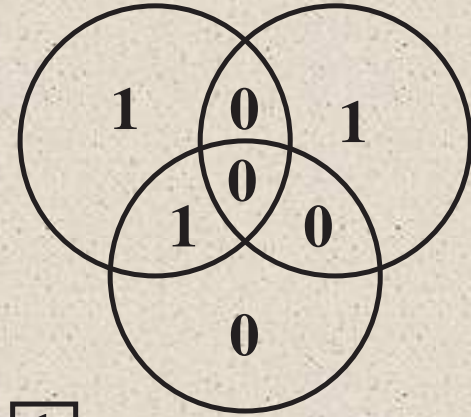
(a)



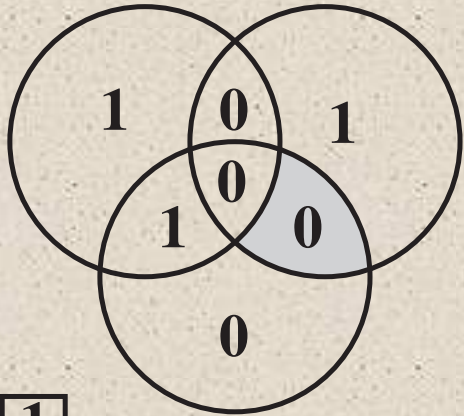
(b)



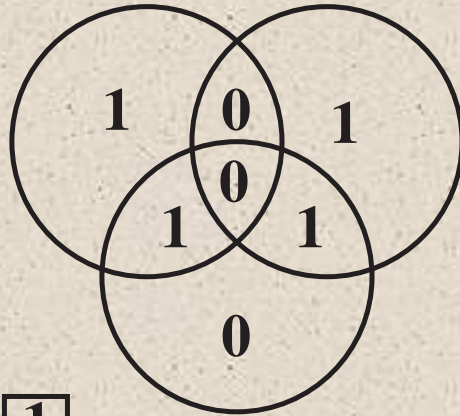
(c)



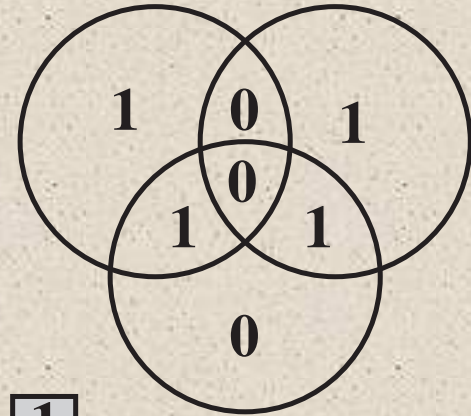
(d)



(e)



(f)



**Figure 5.11 Hamming SEC-DED Code**



# Advanced DRAM Organization

- One of the most critical system bottlenecks when using high-performance processors is the interface to main internal memory
- The traditional DRAM chip is constrained both by its internal architecture and by its interface to the processor's memory bus
- A number of enhancements to the basic DRAM architecture have been explored

+

- The schemes that currently dominate the market are SDRAM and DDR-DRAM

SDRAM

DDR-DRAM

RDRAM

# Synchronous DRAM (SDRAM)

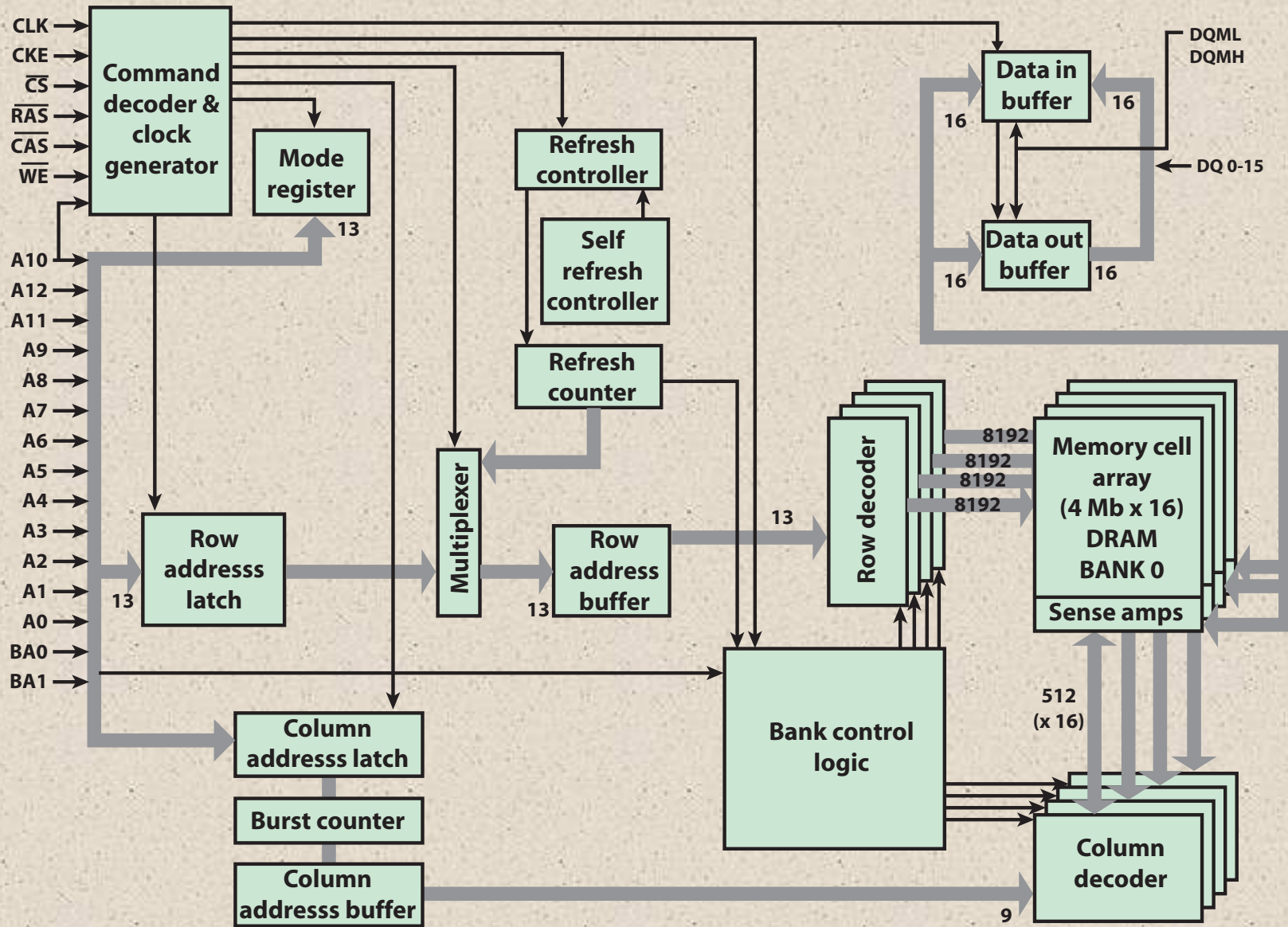


One of the most widely used forms of DRAM

Exchanges data with the processor synchronized to an external clock signal and running at the full speed of the processor/memory bus without imposing wait states

With synchronous access the DRAM moves data in and out under control of the system clock

- The processor or other master issues the instruction and address information which is latched by the DRAM
- The DRAM then responds after a set number of clock cycles
- Meanwhile the master can safely do other tasks while the SDRAM is processing

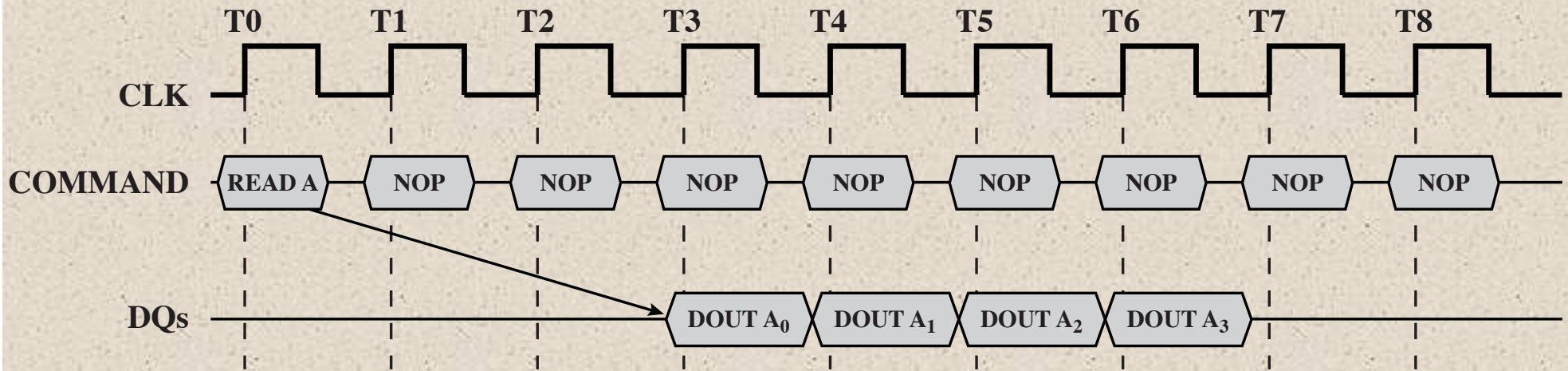


**Figure 5.12 256-Mb Synchronous Dynamic RAM (SDRAM)**

A0 to A12	Address inputs
BA0, BA1	Bank address lines
CLK	Clock input
CKE	Clock enable
$\overline{CS}$	Chip select
$\overline{RAS}$	Row address strobe
$\overline{CAS}$	Column address strobe
$\overline{WE}$	Write enable
DQ0 to DQ15	Data input/output
DQM	Data mask

**Table 5.3**

**SDRAM**  
**Pin**  
**Assignment**  
**s**



**Figure 5.13 SDRAM Read Timing (Burst Length = 4, CAS latency = 2)**



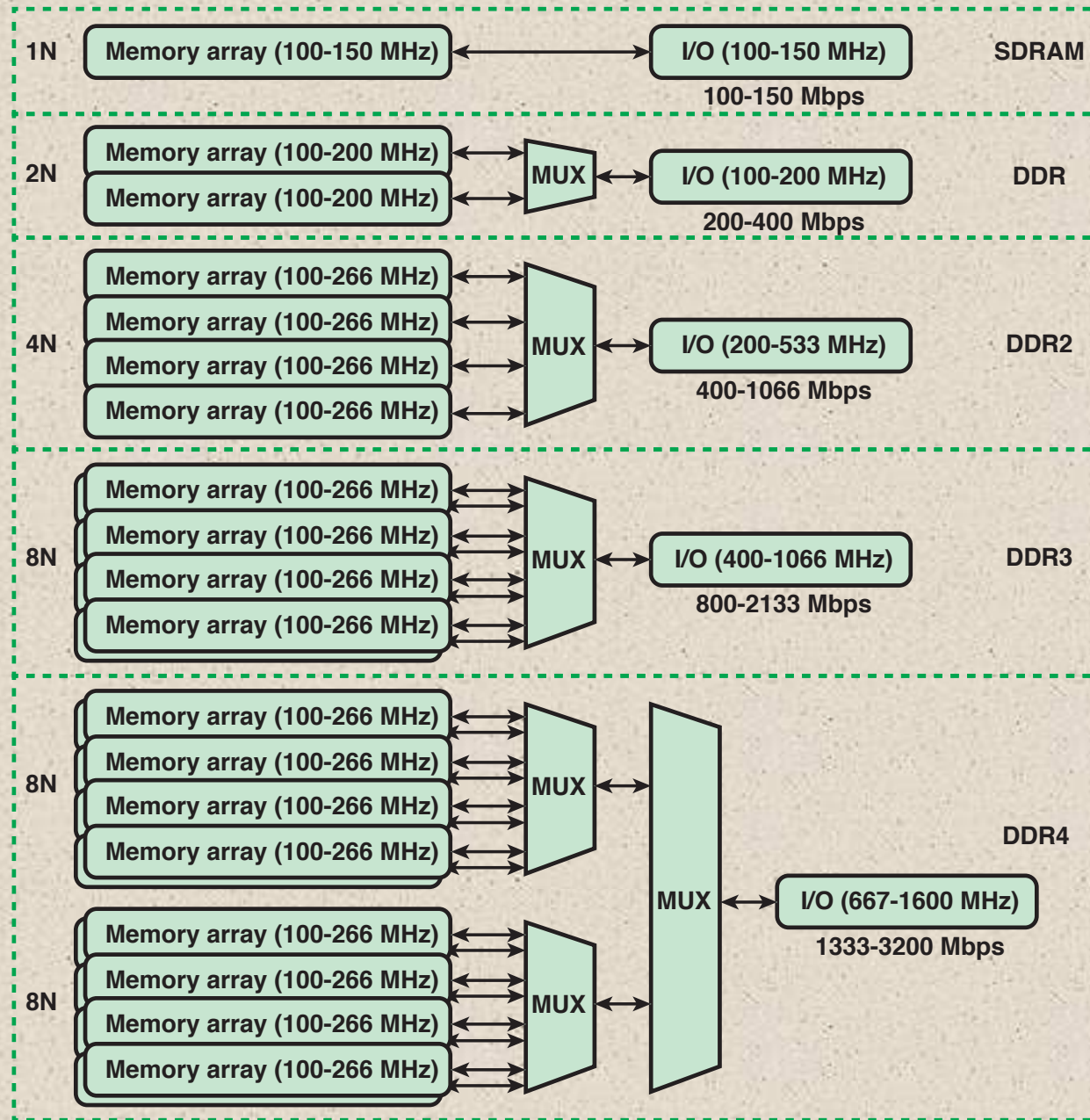
# + Double Data Rate SDRAM (DDR SDRAM)

- Developed by the JEDEC Solid State Technology Association (Electronic Industries Alliance's semiconductor-engineering-standardization body)
- Numerous companies make DDR chips, which are widely used in desktop computers and servers
- DDR achieves higher data rates in three ways:
  - First, the data transfer is synchronized to both the rising and falling edge of the clock, rather than just the rising edge
  - Second, DDR uses higher clock rate on the bus to increase the transfer rate
  - Third, a buffering scheme is used



	<b>DDR1</b>	<b>DDR2</b>	<b>DDR3</b>	<b>DDR4</b>
Prefetch buffer (bits)	2	4	8	8
Voltage level (V)	2.5	1.8	1.5	1.2
Front side bus data rates (Mbps)	200—400	400—1066	800—2133	2133—4266

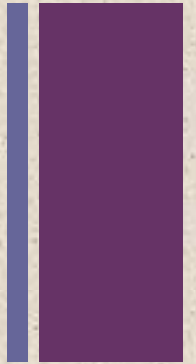
**Table 5.4**  
**DDR Characteristics**



**Figure 5.14 DDR Generations**

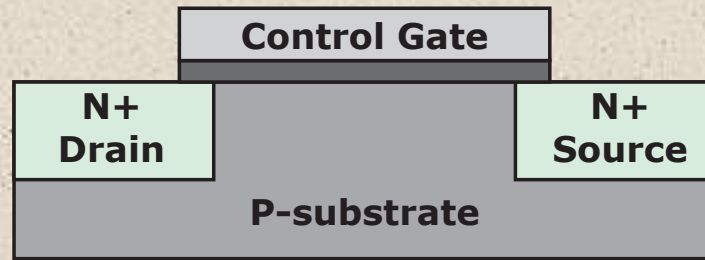


# Flash Memory

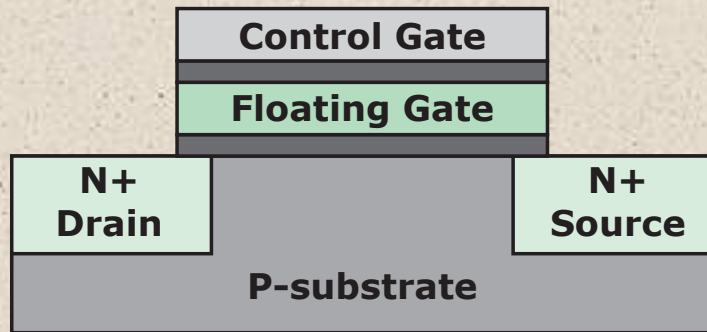


- Used both for internal memory and external memory applications
- First introduced in the mid-1980's
- Is intermediate between EPROM and EEPROM in both cost and functionality
- Uses an electrical erasing technology like EEPROM
- It is possible to erase just blocks of memory rather than an entire chip
- Gets its name because the microchip is organized so that a section of memory cells are erased in a single action
- Does not provide byte-level erasure
- Uses only one transistor per bit so it achieves the high density of EPROM

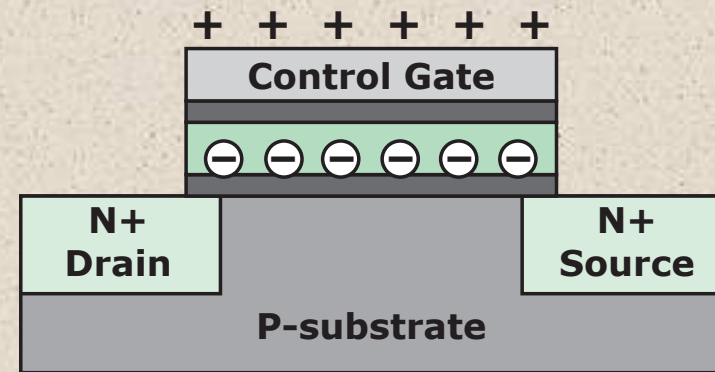




(a) Transistor structure



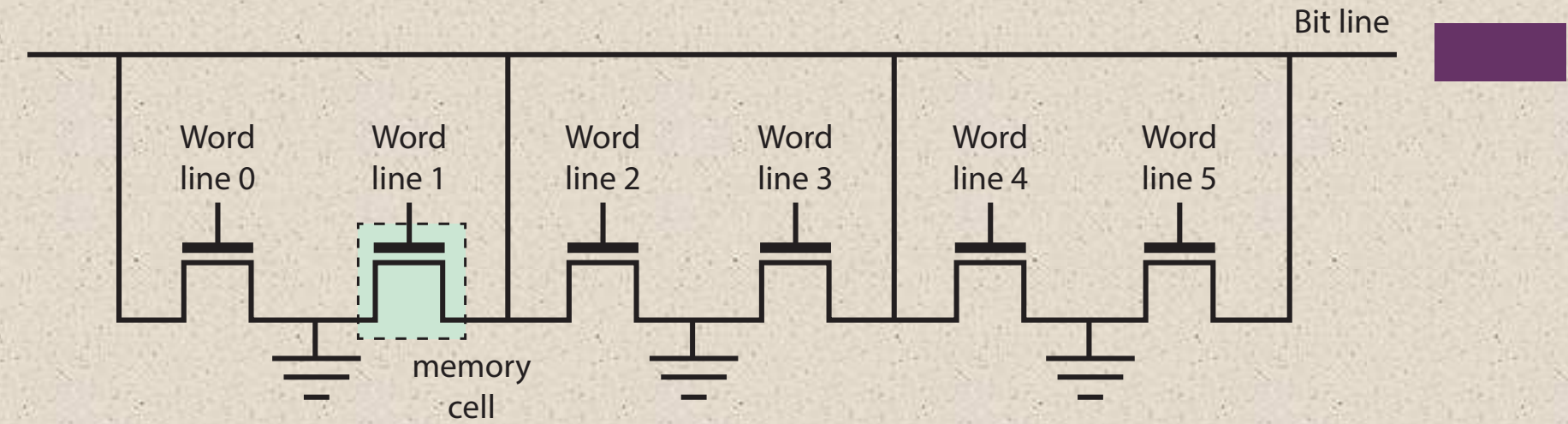
(b) Flash memory cell in one state



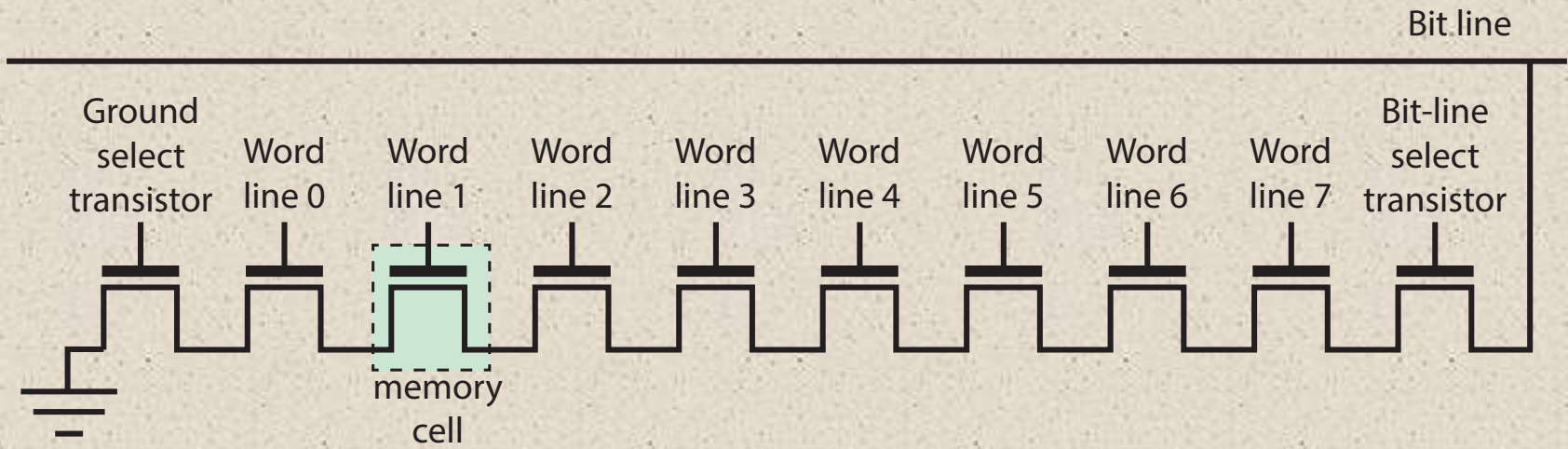
(c) Flash memory cell in zero state

**Figure 5.15 Flash Memory Operation**



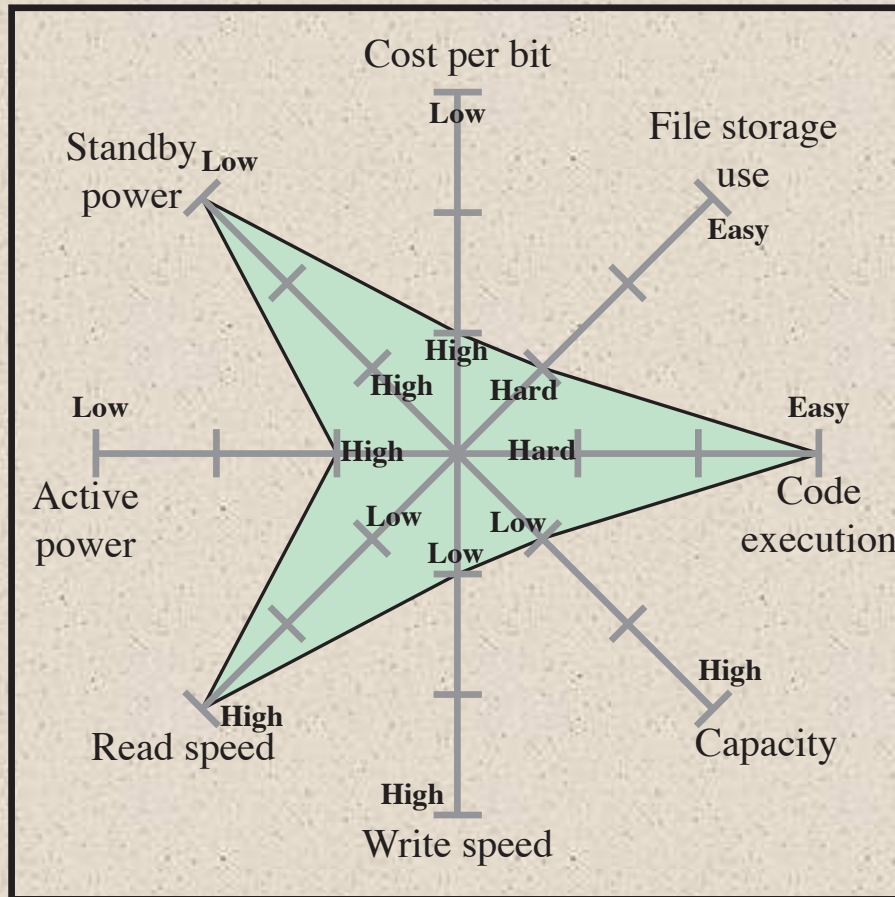


**(a) NOR flash structure**

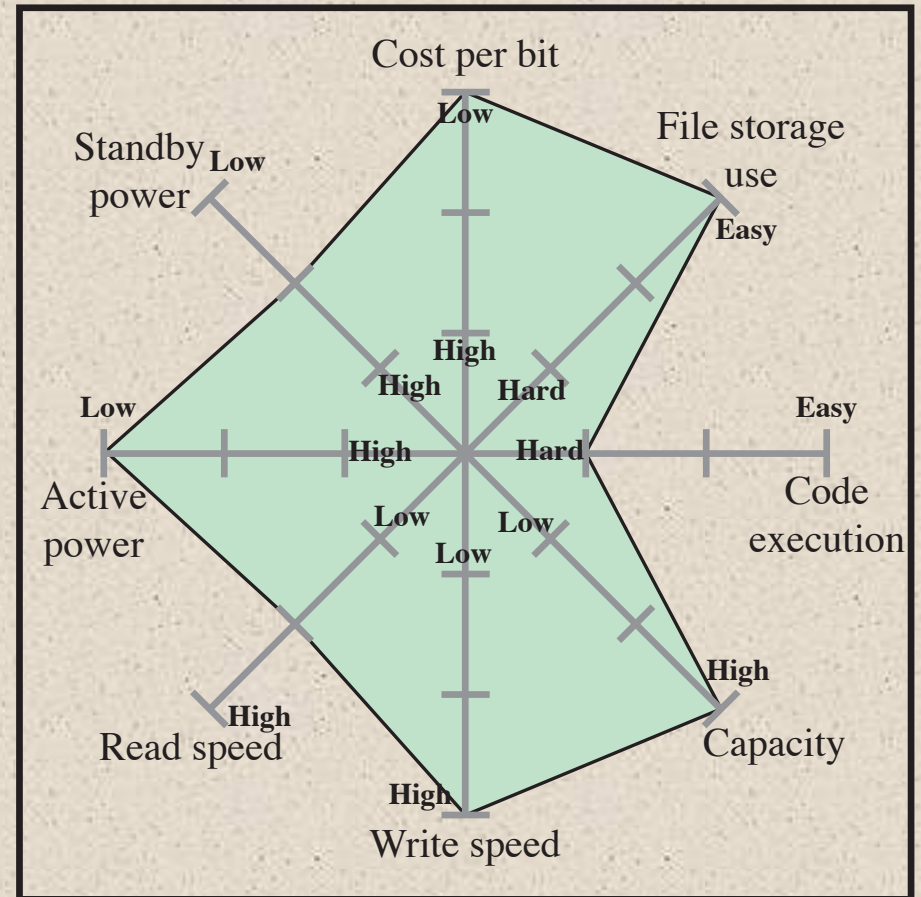


**(b) NAND flash structure**

**Figure 5.16 Flash Memory Structures**



(a) NOR



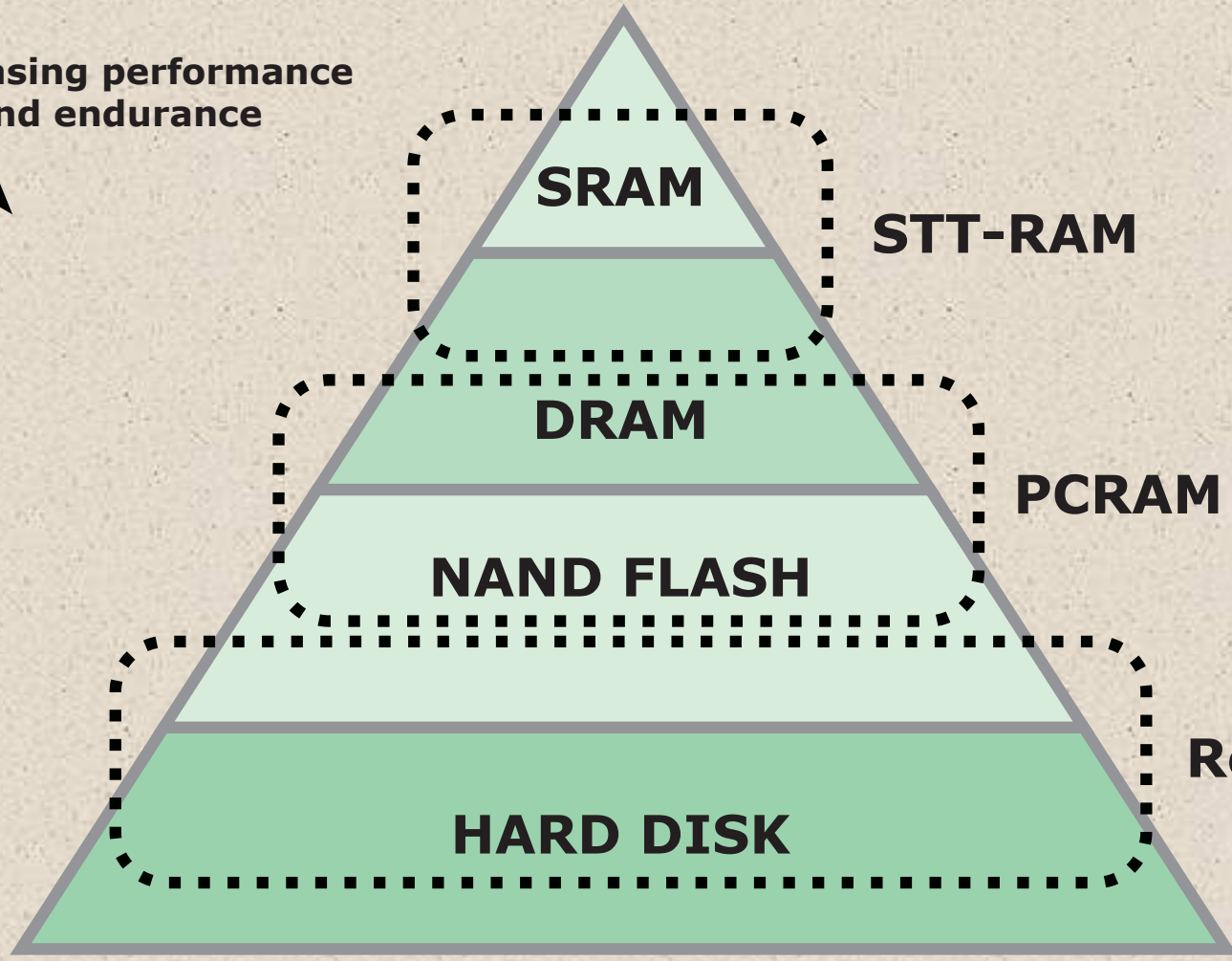
(b) NAND

**Figure 5.17 Kiviat Graphs for Flash Memory**

Increasing performance  
and endurance



Decreasing cost  
per bit,  
increasing capacity  
or density



SRAM

STT-RAM

DRAM

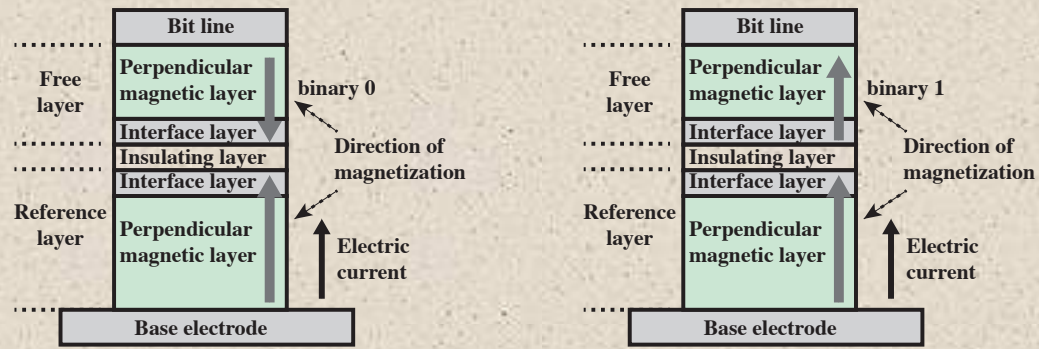
PCRAM

NAND FLASH

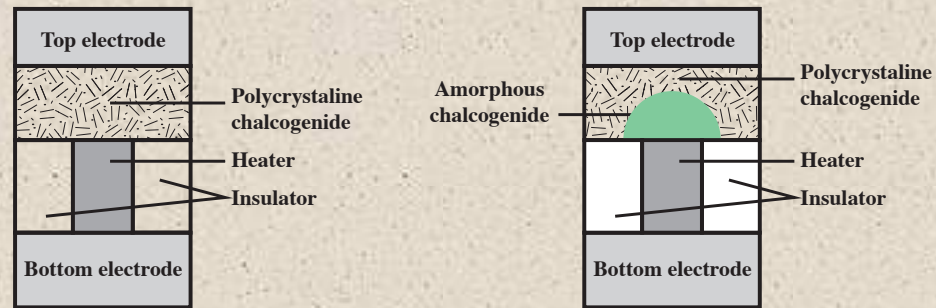
ReRAM

HARD DISK

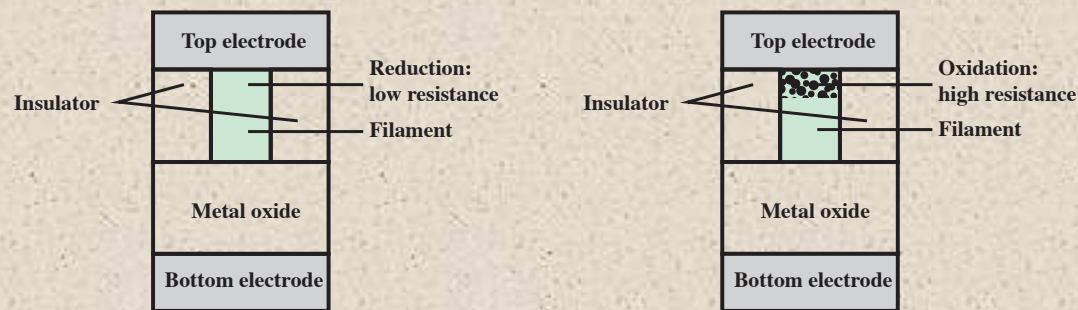
**Figure 5.18 Nonvolatile RAM within the Memory Hierarchy**



(a) STT-RAM



(b) PCRAM



(c) ReRAM

**Figure 5.19 Nonvolatile RAM Technologies**



# + Summary

## Chapter 5

### Internal Memory

- Semiconductor main memory
  - Organization
  - DRAM and SRAM
  - Types of ROM
  - Chip logic
  - Chip packaging
  - Module organization
  - Interleaved memory
- Error correction
- DDR DRAM
  - Synchronous DRAM
  - DDR SDRAM
- Flash memory
  - Operation
  - NOR and NAND flash memory
- Newer nonvolatile solid-state memory technologies